M5M5256DFP,VP-55LL,-70LL,-70LLI, -55XL,-70XL

262144-BIT (32768-WORD BY 8-BIT) CMOS STATIC RAM

DESCRIPTION

The M5M5256DFP,VP is 262,144-bit CMOS static RAMs organized as 32,768-words by 8-bits which is fabricated using high-performance 3 polysilicon CMOS technology. The use of resistive load NMOS cells and CMOS periphery results in a high density and low power static RAM. Stand-by current is small enough for battery back-up application. It is ideal for the memory systems which require simple interface.

Especially the M5M5256DVP are packaged in a 28-pin thin small outline package.

FEATURE

| | Access | Oprating | Power supply current | | | |
|--|---------------|-------------|----------------------|---|--|--|
| Туре | time (max) | Temperature | Active (max) | Stand-by (max) | | |
| M5M5256DFP,VP-55LL M5M5256DFP,VP-70LL | 55ns 70ns | 0~70°C | | 20µA (Vcc=5.5V) | | |
| M5M5256DFP,VP-70LLI | 70ns | -40~85°C | 50mA (Vcc=5.5V) | 40μA (Vcc=5.5V) | | |
| M5M5256DFP,VP-55XL M5M5256DFP,VP-70XL | 55ns 70ns | 0~70°C | | 5μA (Vcc=5.5V) 0.05μA (Vcc=3.0V, Typical) | | |

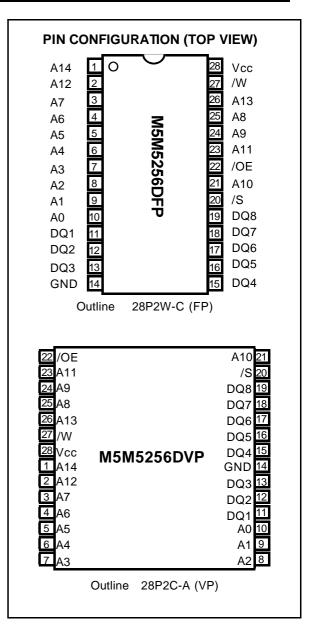
- •Single +5V power supply
- •No clocks, no refresh
- •Data-Hold on +2.0V power supply
- •Directly TTL compatible : all inputs and outputs
- •Three-state outputs : OR-tie capability
- •/OE prevents data contention in the I/O bus
- •Common Data I/O
- •Battery backup capability
- •Low stand-by current 0.05µA(typ.)

PACKAGE

M5M5256DFP : 28 pin 450 mil SOP M5M5256DVP : 28pin 8 X 13.4 mm² TSOP

APPLICATION

Small capacity memory units



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FUNCTION

The operation mode of the M5M5256DFP,VP is determined by a combination of the device control inputs /S, /W and /OE. Each mode is summarized in the function table.

A write cycle is executed whenever the low level /W overlaps with the low level /S. The address must be set up before the write cycle and must be stable during the entire cycle. The data is latched into a cell on the trailing edge of /W, /S, whichever occurs first, requiring the set-up and hold time relative to these edge to be maintained. The output enable /OE directly controls the output stage. Setting the /OE at a high level, the output stage is in a high-impedance state, and the data bus contention problem in the write cycle is eliminated.

A read cycle is executed by setting /W at a high level and /OE at a low level while /S are in an active state.

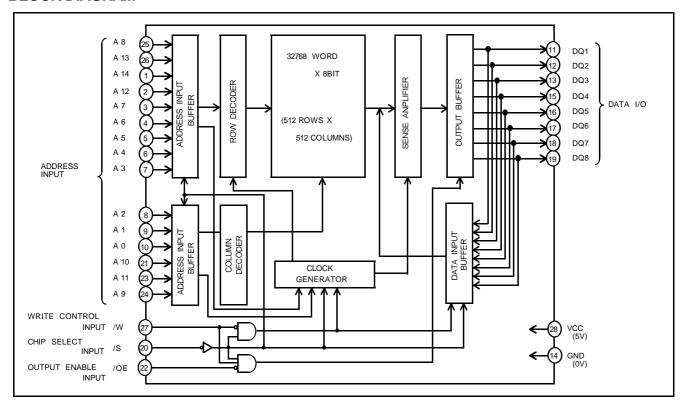
When setting /S at a high level, the chip is in a non-selectable mode in which both reading and writing are disabled. In this mode, the output stage is in a high-impedance state, allowing OR-tie with other chips and memory expansion by /S. The power supply current is reduced as low as the stand-by current which is specified as Icc3 or Icc4, and the memory data can be held at +2V power supply, enabling battery back-up operation during power failure or power-down operation in the non-selected mode.

FUNCTION TABLE

| /S | /W | /OE | Mode | DQ | Icc |
|----|----|-----|---------------|----------------|----------|
| Н | Х | Х | Non selection | High-impedance | Stand-by |
| L | L | Χ | Write | DIN | Activ e |
| L | Н | L | Read | Dоит | Activ e |
| L | Н | I | | High-impedance | Activ e |

Note • "H" and "L" in this table mean VIH and VIL, respectively.

BLOCK DIAGRAM





^{• &}quot;X" in this table should be "H" or "L".

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ABSOLUTE MAXIMUM RATINGS

| Symbol | Parameter | Conditions | Ratings | Unit |
|------------------|-----------------------|---------------------|----------------------------|------|
| Vcc | Supply voltage | | -0.3*~7.0 | V |
| Vı | Input voltage | With respect to GND | -0.3*~Vcc+0.3 (Max 7.0) | ٧ |
| Vo | Output voltage | | 0~Vcc | V |
| Pd | Power dissipation | Ta=25°C | 700 | mW |
| Topr | Operating temperature | -LL,-XL | 0~70 | 9 |
| I opr | Operating temperature | -LLI | -40~85 | °C |
| T _{stg} | Storage temperature | | -65~150 | ô |

^{* -3.0}V in case of AC (Pulse width < 30ns)

DC ELECTRICAL CHARACTERISTICS (Vcc=5V±10%, unless otherwise noted)

| 0 | | Test conditions | | L | imits | | | |
|------------------|---------------------------------------|---|-----------------------|----------|-------------|-----|-------------|------|
| Symbol | Parameter | i est condi | tions | | Min | Тур | Max | Unit |
| VIH | High-level input voltage | | | | 2.2 | | Vcc +0.3 | V |
| VIL | Low-level input voltage | | | | -0.3* | | 0.8 | V |
| V _{OH1} | High-level output voltage 1 | Іон=-1 m А | | | 2.4 | | | V |
| V _{OH2} | High-level output voltage 2 | Iон=-0.1mA | | | Vcc -0.5 | | | V |
| Vol | Low-level output voltage | lot=2mA | | | | | 0.4 | V |
| lı | Input current | V ₁ =0~Vcc | V _I =0~Vcc | | | | ±1 | μΑ |
| lo | Output current in off-state | /S=Vih or or /OE=Vih, Vi/o=0~Vcc | | | | | ±1 | μΑ |
| | | /S<0.2V, Other inputs<0.2V or >Vcc-0.2V | | 55ns | | 30 | 45 | mA |
| lcc1 | Active supply current (AC, MOS level) | | | V 70ns | | 25 | 40 | |
| | (10, 1100 1010) | Output-open 1M | | | | 2 | 4 | |
| | A.C | /S=V _{IL} , 55ns other inputs=V _{IH} or V _{IL} 70ns | | | | 30 | 50 | mA |
| lcc2 | Active supply current (AC, TTL level) | | | | | 25 | 45 | |
| | (****) | Output-open | | 1MHz | | 4 | 8 |] |
| | | | ~25°C | -LL,-LLI | | | 2 | |
| | | | ~25 C | -XL | | 0.1 | 0.4 | μΑ |
| | | (C.)/aa 0 0)/ | ~40°C | -LL,-LLI | | | 6 | |
| lcc3 | Stand-by current | /S>Vcc-0.2V, other inputs=0~Vcc | ~40 C | -XL | | | 1.2 | |
| | | other inputs=0~vcc | ~70°C | -LL,-LLI | | | 20 | |
| | | | 700 | -XL | | | 5 | |
| | | ~85° | ~85°C | -LLI | | | 40 | |
| lcc4 | Stand-by current | /S=Vін, other inputs=0 | ~Vcc | | | | 3 | mA |

^{* -3.0}V in case of AC (Pulse width \leq 30ns)

CAPACITANCE (Vcc=5V±10%, unless otherwise noted)

| | | | | 11.20 | | |
|--------|--------------------|--|-----|-------|-----|------|
| Symbol | Parameter | Test conditions | Min | Тур | Max | Unit |
| Cı | Input capacitance | V _I =GND, V _I =25mVrms, f=1MHz | | | 6 | pF |
| Со | Output capacitance | Vo=GND,Vo=25mVrms, f=1MHz | | | 8 | рF |

Note 0: Direction for current flowing into an IC is positive (no mark).

- 1: Typical value is one at Ta = 25°C.
- 2: C₁, C₀ are periodically sampled and are not 100% tested.



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AC ELECTRICAL CHARACTERISTICS (Vcc=5V±10%, unless otherwise noted)

(1) READ CYCLE

| | | | Limits | | | | |
|----------|------------------------------------|-------|--------|-----|---------------|------|--|
| Symbol | Parameter | -55LL | , 55XL | | -70LLI, XL | Unit | |
| | | Min | Max | Min | Max | | |
| tcr | Read cycle time | 55 | | 70 | | ns | |
| ta(A) | Address access time | | 55 | | 70 | ns | |
| ta(S) | Chip select access time | | 55 | | 70 | ns | |
| ta(OE) | Output enable access time | | 30 | | 35 | ns | |
| tdis(S) | Output disable time after /S high | | 20 | | 25 | ns | |
| tdis(OE) | Output disable time after /OE high | | 20 | | 25 | ns | |
| ten(S) | Output enable time after /S low | 5 | | 5 | | ns | |
| ten(OE) | Output enable time after /OE low | 5 | | 5 | | ns | |
| t∨(A) | Data valid time after address | 10 | | 10 | | ns | |

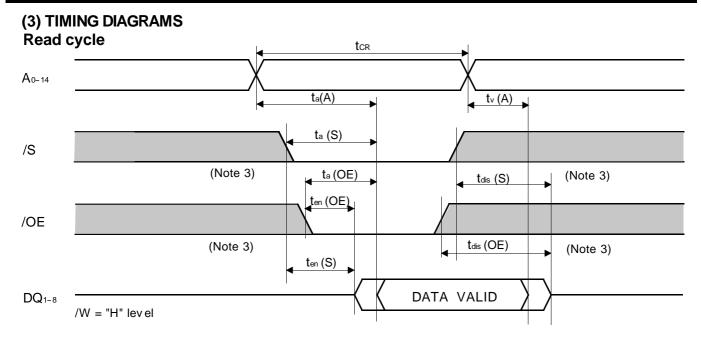
(2) WRITE CYCLE

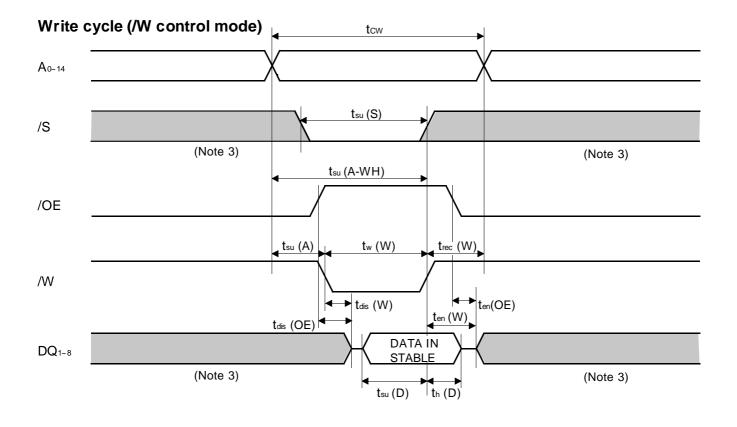
| | Parameter | | Limits | | | | |
|---------------------|--|-----|--------------|--------|---------------|------|--|
| 0 | | | -55LL, -55XL | | -70LL,-70LLI, | | |
| Symbol | | | -33XL | -70 XL | | Unit | |
| | | Min | Max | Min | Max | | |
| tcw | Write cycle time | 55 | | 70 | | ns | |
| t _w (W) | Write pulse width | 40 | | 50 | | ns | |
| tsu(A) | Address setup time | 0 | | 0 | | ns | |
| tsu(A-WH) | Address setup time with respect to /W high | 50 | | 65 | | ns | |
| tsu(S) | Chip select setup time | 50 | | 65 | | ns | |
| t _{su} (D) | Data setup time | 25 | | 30 | | ns | |
| th(D) | Data hold time | 0 | | 0 | | ns | |
| trec(W) | Write recovery time | 0 | | 0 | | ns | |
| tdis(W) | Output disable time from /W low | | 20 | | 25 | ns | |
| tdis(OE) | Output disable time from /OE high | | 20 | | 25 | ns | |
| t _{en} (W) | Output enable time from /W high | 5 | | 5 | | ns | |
| ten(OE) | Output enable time from /OE low | 5 | | 5 | | ns | |

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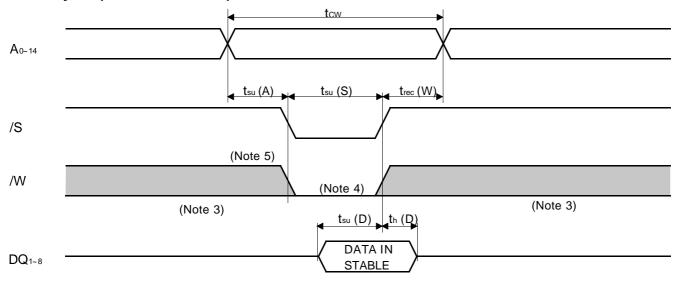


M5M5256DFP,VP-55LL,-70LL,-70LLI,

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Write cycle (/S control mode)



Note 3: Hatching indicates the state is "don't care".

- 4: Writing is executed in overlap of /S and /W low.
- 5: If /W goes low simultaneously with or prior to /S, the outputs remain in the high impedance state.
- 6 : Don't apply inverted phase signal externally when DQ pin is output mode.
- 7: ten, tdis are periodically sampled and are not 100% tested.

(4) MEASUREMENT CONDITIONS

Input pulse level VIH=2.4V, VIL=0.6V

Input rise and fall time 5ns

Reference level VoH=VoL=1.5V

Output load Fig.1 CL=50pF (-55LL,-55XL)

CL=100pF (-70LL,-70LLI,-70XL)

CL=5pF (for ten,tdis)

Transition is measured ±500mV from steady

state voltage. (for ten,tdis)

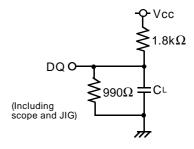


Fig.1 Output load

M5M5256DFP, VP-55LL, -70LL, -70LLI, -55XL,-70XL 262144-BIT (32768-WORD BY 8-BIT) CMOS STATIC RAM

POWER DOWN CHARACTERISTICS

(1) ELECTRICAL CHARACTERISTICS (Vcc=5V±10%, unless otherwise noted)

| Cumahad | Doromotor | Toot or | . n. al:4: n. n. a | | L | Limits | | I I m i 4 |
|----------|---------------------------|--|--------------------|----------|-----|---------|-----|-----------|
| Symbol | Parameter | l est co | onditions | 5 | Min | Тур | Max | Unit |
| VCC (PD) | Power down supply voltage | | | 2 | | | V | |
| 1.7 | Ohim a ala at immed 10 | $2.2V \leq VCC(PD)$ | | | 2.2 | | | V |
| VI (/S) | Chip select input /S | 2V≤ Vcc(PD) ≤ 2 | .2V | | | VCC(PD) | | V |
| | Power down supply current | Vcc = 3V,/S > Vcc-0.2V, Other inputs=0~Vcc | ~25°C | -LL,-LLI | | | 1 | |
| | | | | -XL | | 0.05 | 0.2 | |
| | | | ~40°C | -LL,-LLI | | | 3 | |
| ICC (PD) | | | | -XL | | | 0.6 | μA |
| | | | ~70°C | -LL,-LLI | | | 10 | - |
| | | | | -XL | | | 2 | |
| | | | ~85°C | -LLI | | | 20 | |

(2) TIMING REQUIREMENTS (Vcc=5V±10%, unless otherwise noted)

| | <u>_</u> | | | | | |
|-----------|--------------------------|-----------------|-----|-----|-----|------|
| Symbol | Parameter | Test conditions | Min | Тур | Max | Unit |
| tsu (PD) | Power down set up time | | 0 | | | ns |
| trec (PD) | Power down recovery time | | tCR | | | ns |

(3) POWER DOWN CHARACTERISTICS

/S control mode

Vcc 2.2V /S /S > Vcc-0.2V

RENESAS LSIs

M5M5256DFP, VP-55LL, -70LL, -70LLI,

-55XL,-70XL

262144-BIT (32768-WORD BY 8-BIT) CMOS STATIC RAM

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